

# Influence of Missing Array Elements on Phase Aberration Correction for Medical Ultrasound

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**Abstract**—The influence of missing array elements on aberration correction based on time delay estimation using radio frequency signals of neighboring elements is experimentally investigated. Normalized cross correlation and sum of absolute differences are employed as the cost functions in aberration estimation. Their performance is tested through various measurements using radio frequency data acquired with a 3.3 MHz, 64-element phased array. Variation of cost functions and phase estimation error are obtained for different combinations of number of missing elements, amount of aberration, and noise level. For a particular combination of these parameters, a set of B-scan images is reconstructed and presented to examine the effects of residual phase errors on image quality.

## I. INTRODUCTION

PHASE ERRORS induced by tissue inhomogeneities critically affect the image quality of phased array ultrasound scanners [1], [2]. Various techniques had been developed to estimate and correct phase aberrations [3]–[11]. Time delay estimation via minimization of cross correlation [5] and sum of absolute difference [12] between the sampled radio frequency (RF) echo signals of neighboring elements has been shown to perform well. The accuracy of aberration estimation is seriously degraded, however, by the presence of missing array elements [13], [14]. Such elements arise due to discontinuous acoustic windows into the body, loss of contact between the array and the body wall, and electrical or mechanical defects in the array.

Detection of relative phase differences between missing elements is not possible in aberration correction techniques based on time delay estimation between RF signals on neighboring elements. To obtain the complete aberration pattern for proper phasing of the whole aperture, differential delays at missing elements can be interpolated using phase estimates between the nearest active elements. A cost function is used for every correction technique based on a measure of the signal covariance. The accuracy of phase estimation between two RF signals is limited by the level of their covariance. The spatial variation of the cost function, used for time

delay estimation across the array, is a critical measure of phase estimation between the nearest operable elements. The covariance depends on not only the spatial distance, but is also critically influenced by the aberration level and signal to noise ratio (SNR) of RF signals. Therefore, for aberration correction with inactive elements, variation of the cost function must be measured for different numbers of missing elements with different aberration and noise levels.

Various measurements of the cost function and phase estimation error have been performed to test the performance of aberration estimation with missing elements. The measurements were obtained on experimental RF data acquired from a standard tissue-mimicking phantom. Additionally, a set of B-scan images of the phantom was reconstructed with inactive elements to qualitatively test the performance of correction schemes employing different cost functions in aberration estimation. In all measurements, phase distortions and inactive elements are simulated by inserting random time shifts and assigning zero valued samples to the corresponding elements, respectively.

Aberration correction based on time delay estimation between neighboring elements is described in the next section. Aberration estimation with missing elements is discussed also in this section. Measurements to test the influence of inactive elements on the cost function and estimation error with different rms aberration and SNR levels are presented in Section III. B-scan images of the phantom and their qualitative comparison are given in Section IV.

## II. ABERRATION CORRECTION

Phased array adaptive beamformers involve estimation of phase aberration profiles across the array, and compensation based on these estimates. Compensation can easily be realized by updating focusing delays using the estimated aberration delays. The aberration profile can be obtained by estimating the time delay between an element signal and a reference. Such a reference signal can be formed by summing the signals of all elements or of a subgroup of array elements [13]. An alternative way is to measure the relative time shifts between neighboring elements. The final element delays, then, are obtained by unwrapping the measured differential delays [15]. The measurement of relative delay in either case is a typical time delay estimation problem [16].

Time delay estimation techniques considered here will be evaluated with missing elements, aberration, and finite SNR.

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For this purpose, we define cost functions and test their dependence on these parameters. Thus, the two sampled signals,  $S_m^\alpha$  and  $S_n^\alpha$ , used for time delay estimation are defined as:

$$\begin{aligned} S_m^\alpha &= X_m + c_m(\alpha)W_1 \\ S_n^\alpha &= X_n + c_n(\alpha)W_2, \end{aligned} \quad (1)$$

where  $X_m$  and  $X_n$  are noise free RF signals,  $W_1$  and  $W_2$  are uncorrelated Gaussian random noise signals having the same bandwidth as the RF signals, and  $c_m(\alpha)$  and  $c_n(\alpha)$  are coefficients used to obtain different SNR levels. These coefficients are defined as:

$$\begin{aligned} c_m(\alpha) &= \frac{1}{10^{\alpha/20}} \sqrt{\frac{\sum_{i=1}^M X_m(i)^2}{\sum_{i=1}^M W_1(i)^2}} \\ c_n(\alpha) &= \frac{1}{10^{\alpha/20}} \sqrt{\frac{\sum_{i=1}^M X_n(i)^2}{\sum_{i=1}^M W_2(i)^2}}, \end{aligned} \quad (2)$$

where  $M$  is the length of the time window and  $\alpha$  is the desired SNR level (dB) for both  $S_m^\alpha$  and  $S_n^\alpha$ .

Cross correlation of two such signals is widely used to estimate relative time delay. The normalized cross-correlation function (NCC) for the sampled signals,  $S_m^\alpha$  and  $S_n^\alpha$ , is expressed in (3) (see below) where  $S_n^\alpha(i)$  is the  $i$ th sample of the signal from  $n$ th element, and the  $\bar{S}_n^\alpha$  is the mean value computed over the corresponding window. The delay  $u_n$  is the aberration of the  $n$ th element's signal. The best match of two signals is achieved at the maximum correlation value where the maximizing parameter,  $k$ , corresponds to the time delay between  $S_m^\alpha$  and  $S_n^\alpha$ , i.e.,  $k = u_m - u_n$ . Normalization is used to prevent wrong decisions due to signal fluctuations in different time windows.

The sum of absolute differences (SAD) has been used as a computationally simpler cost function in many minimization problems [16], [19]. For time delay estimation, SAD of the sampled signals  $S_m^\alpha$  and  $S_n^\alpha$  can be defined as:

$$E_{m,n}(k, u, \alpha) = \sum_{i=1}^M |S_m^\alpha(i + u_m) - S_n^\alpha(i + k + u_n)|. \quad (4)$$

The best match of  $S_m^\alpha$  and  $S_n^\alpha$  results in the minimum SAD value. Thus, the value of  $k$  which minimizes the SAD corresponds to the time delay difference between the signals  $S_m^\alpha$  and  $S_n^\alpha$ .

A computationally much simpler cost function is obtained using reduced bit density in the digital representation of signals [16], [19]. As the limiting case, the SAD function can be

computed using signal samples quantized to a single bit (1-b SAD) [12]:

$$D_{m,n}(k, u, \alpha) = \sum_{i=1}^M x_m^\alpha(i + u_m) \oplus x_n^\alpha(i + k + u_n), \quad (5)$$

where  $x_n^\alpha(i)$  is the one bit representation of  $S_n^\alpha(i)$ , and  $\oplus$  is the bitwise logic *exclusive-or* operation. Note that such a simplification is not possible for NCC (3) because of the normalization.

To obtain the total aberration pattern, time delay estimation outlined above must be repeated for all neighboring element pairs. Following measurement of the relative aberration delays, an estimate of the resultant aberration delay time,  $\tau_n$ , for the  $n$ th element is obtained by phase unwrapping:

$$\tau_n = \sum_{j=2}^n \Delta\tau_{j,j-1} \quad (6)$$

where  $\Delta\tau_{j,j-1}$  is the differential delay between the  $j$ th and  $(j-1)$ th elements.

Differential delays cannot be computed between any pair of elements including an inactive element. For example, attempts to obtain the complete aberration pattern with a single missing element result in forming two phase patterns over the subapertures on either side of the inactive element. While elements of each subaperture are phased properly, the relative phasing of the two subapertures with respect to each other may not be correct. This can cause significant degradation in image quality. To handle this problem, O'Donnell and Engeler [14] have reported a simple technique involving interpolation of the lost differential delays. In this scheme, the relative phase between two nearest operable elements on both sides of inactive elements is estimated using cross correlation, and it is evenly distributed over the missing elements. If the elements between  $i$  and  $i+r$  for  $r > 1$  are inactive, then the differential delay between the  $n$ th and  $(n-1)$ th elements,  $\Delta\tau_{n,n-1}$ , ( $i < n \leq i+r$ ) is:

$$\Delta\tau_{n,n-1} = \frac{\Delta\tau_{i+r,i}}{r}. \quad (7)$$

As long as the estimation is carried out on neighboring elements, this approach can be directly applicable in aberration estimation independent of the cost function. Our measurements using NCC, SAD, and 1-b SAD are based on this approach.

### III. MEASUREMENTS

The influence of missing elements on phase aberration has been experimentally tested. In particular, both variation of the cost function and phase estimation error have been

$$C_{m,n}(k, u, \alpha) = \frac{\sum_{i=1}^M \{S_m^\alpha(i + u_m) - \bar{S}_m^\alpha\} \{S_n^\alpha(i + k + u_n) - \bar{S}_n^\alpha\}}{\sqrt{\sum_{i=1}^M \{S_m^\alpha(i + u_m) - \bar{S}_m^\alpha\}^2 \sum_{i=1}^M \{S_n^\alpha(i + k + u_n) - \bar{S}_n^\alpha\}^2}}, \quad (3)$$

examined with different numbers of missing elements, aberrations and noise levels. Measurements used RF data acquired from a standard graphite-gel AIUM resolution phantom with a conventional 3.33 MHz, 64-element, 15 mm phased array transducer [5], [15]. RF A-scans were recorded for every possible combination of transmitter and receiver elements using 10-bit, 17.76 MHz analog to digital conversion. All measurements and image reconstruction were performed by digitally processing the recorded data to emulate a real-time adaptive digital imaging system.

To reduce phase quantization effects, the sampling rate was increased by 8 times using digital interpolation resulting in an effective clock frequency of 142 MHz corresponding to a phase accuracy of  $2\pi/43$ . For all measurements, a fixed transmit focus at 80 mm and dynamic receive focusing were employed. NCC and SAD computations were carried out on RF signals from diffuse scatterers within a 20 mm axial window located 60 mm away from the aperture. The transmit focus was purposely placed outside the estimation window to simulate typical operating conditions.

#### A. Variation of Cost Function

Fullword NCC, fullword SAD, and 1-b SAD functions were measured for different numbers of missing elements and rms aberration levels. For these measurements, phase distortions were simulated using a random aberration pattern, i.e., electronic aberration is employed. The pattern is band-pass filtered to eliminate high frequency variations which are not practical. The resultant phase profile has a random sinusoidal pattern (see Fig. 6). Different rms aberration levels on the array are achieved by scaling the amplitude of the same aberration pattern.

Equations (3), (4), and (5) were used with the experimental data to compute the cost functions. The signal  $X_n$  used in these expressions represents an actual RF A-scan signal at the  $n$ th element. The maximizing parameter  $k$  is set to zero, and the parameter  $\alpha$  indicating the SNR level is set to infinity. In other words, the cost functions are computed at zero time lag with SNR the same as that of actual RF data  $X_n$ . Furthermore, computations are carried out on speckle RF signals from different pairs of array elements. The spacing between these elements corresponds to the number of missing elements. The results of different element pairs with equal spacing are averaged. We make the following definitions to clarify these manipulations:

$$\begin{aligned} C_r^u &= \frac{1}{N-r} \sum_{m=1}^{N-r} C_{m,m+r}(0, u, \infty) \\ E_r^u &= \frac{1}{N-r} \sum_{m=1}^{N-r} E_{m,m+r}(0, u, \infty) \\ D_r^u &= \frac{1}{N-r} \sum_{m=1}^{N-r} D_{m,m+r}(0, u, \infty). \end{aligned} \quad (8)$$

In addition to this averaging, all measurements are repeated on five different sets of speckle data. Based on these measure-

ments, the rms value and standard deviation of each function, therefore, are defined as:

$$\begin{aligned} \overline{C_r^u} &= \sqrt{\frac{1}{5} \sum_{i=1}^5 \{C_r^u\}_i^2} \\ \overline{E_r^u} &= \sqrt{\frac{1}{5} \sum_{i=1}^5 \{E_r^u\}_i^2} \\ \overline{D_r^u} &= \sqrt{\frac{1}{5} \sum_{i=1}^5 \{D_r^u\}_i^2}, \end{aligned} \quad (9)$$

$$\begin{aligned} \sigma_C(u, r) &= \sqrt{\frac{1}{5} \sum_{i=1}^5 (\{C_r^u\}_i - \overline{C_r^u})^2} \\ \sigma_E(u, r) &= \sqrt{\frac{1}{5} \sum_{i=1}^5 (\{E_r^u\}_i - \overline{E_r^u})^2} \\ \sigma_D(u, r) &= \sqrt{\frac{1}{5} \sum_{i=1}^5 (\{D_r^u\}_i - \overline{D_r^u})^2}. \end{aligned} \quad (10)$$

Fig. 1 presents  $\overline{C_r^u}$ ,  $\overline{E_r^u}$ , and  $\overline{D_r^u}$  versus interelement distance,  $r$ , and the rms aberration,  $\bar{u}$ , where

$$\bar{u} = \sqrt{\frac{1}{N} \sum_{j=1}^N u_j^2}. \quad (11)$$

Note that the number of missing elements is identical with the interelement distance,  $r$ , with an offset of one-element distance, i.e., the number of missing elements is equal to  $r-1$  as long as  $r > 0$ . In all figures, both the number of missing elements and inter-element distance are explicitly represented. Also note that magnitude distributions of both SAD and 1-b SAD functions are normalized by their maximum values for presentation on the same figure together with NCC (Figs. 1 and 3).

The NCC function is unity for no missing elements, which corresponds to the autocorrelation of RF signals. The autocorrelation is not affected by inserted phase distortions up to  $0.023 \lambda$  rms aberration ( $\lambda$  is the ultrasound wavelength). The correlation function varies almost linearly with the number of missing elements for zero rms aberration (i.e., the variation on the vertical axis is almost linear). This is in agreement with the van Cittert-Zernike theorem applied to pulsed echo ultrasound [20]. The decrease in magnitude with the number of missing elements shows variable characteristics for different aberration levels, as is evident from the contour distribution in Fig. 1. As expected, the decrease in correlation becomes severe with increasing aberration level. Also, the contours show an asymptotic behavior as a function of aberration level for a very small number of missing elements.

Both fullword SAD and 1-b SAD functions show very similar characteristics. The SAD values for pairs cannot be

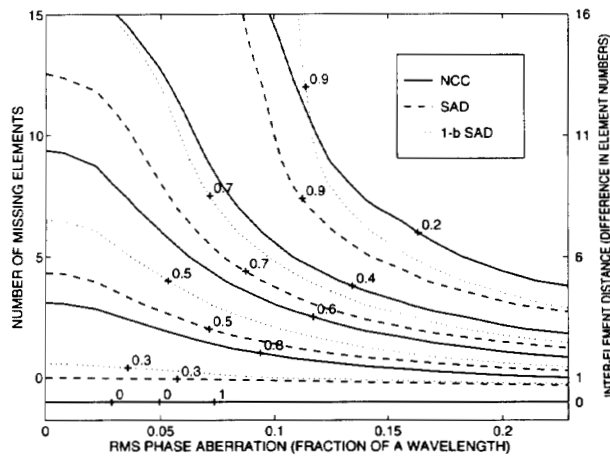


Fig. 1. Magnitude distribution of the cost functions versus the number of missing elements and rms phase aberration.

quantitatively compared to their correlation counterparts. Nevertheless, incremental variation of SAD values can be compared to correlation trends. It can be observed that incremental changes of the functions are comparable. The dependence of SAD functions on the rms aberration level and number of missing elements is similar to that of the correlation function, considering that the increase in the later corresponds to a decrease in the former two. The decrease in 1-b SAD with increase in the number of missing elements is slightly more than that of full word SAD. In general, both SAD functions show similar dependence on the number of missing elements and rms aberration level.

The maximum standard deviation values computed using (10) for NCC, SAD, and 1-bit SAD are within 14, 4, and 6%, respectively, of the corresponding magnitude values of the functions. For up to 8 missing elements with rms aberration less than  $0.15\lambda$ , the standard deviation value of each function is less than 50% of its maximum standard deviation.

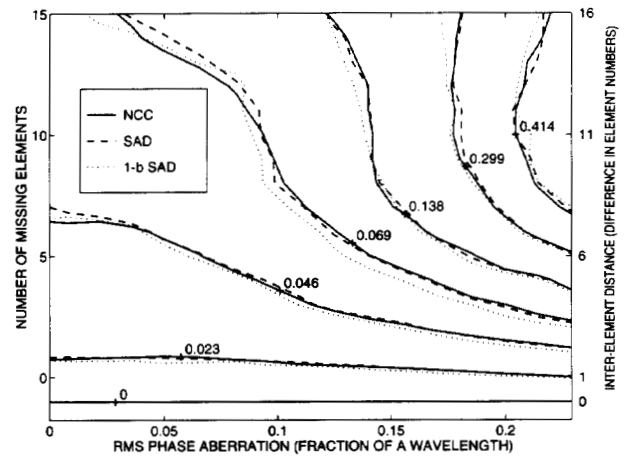
### B. Phase Estimation Error

To directly compare estimation performance using different cost functions, time delay estimation error versus aberration and missing elements was measured for NCC, SAD, and 1-b SAD functions. The measured error is the residual rms phase error between the original and estimated relative aberration delays. Since measurements were performed on different element pairs, the error of each measurement is first averaged over pairs with the same spatial separation:

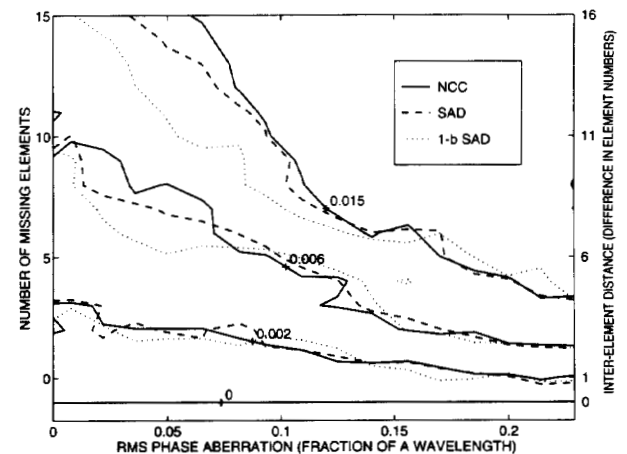
$$\Delta\phi(u, r) = \sqrt{\frac{1}{N-r} \sum_{m=1}^{N-r} \{\Delta\tau_{m, m+r} - (u_m - u_{m+r})\}^2}. \quad (12)$$

Then, the rms of this averaged error and its standard deviation over five different sets of speckle data are obtained:

$$\overline{\Delta\phi(u, r)} = \sqrt{\frac{1}{5} \sum_{i=1}^5 \{\Delta\phi_r^u\}_i^2} \quad (13)$$



(a)



(b)

Fig. 2. Distribution of the residual differential phase errors versus the number of missing elements and rms phase aberration. (a) rms and (b) standard deviation. Contour values are given in fractions of a wavelength. The phase quantization level is  $0.023\lambda$

$$\sigma_{\Delta\phi(u, r)} = \sqrt{\frac{1}{5} \sum_{i=1}^5 \{\{\Delta\phi_r^u\}_i - rms\{\Delta\phi_r^u\}\}^2}.$$

Relative phase differences between element pairs are computed by time delay estimation, and then the above error computations are carried out. Measurements are repeated for all element pairs separated by  $r$  elements, and for different  $\bar{u}$  values. All computations are repeated for each cost function with  $\alpha = \infty$ .

Fig. 2(a) depicts  $\overline{\Delta\phi(u, r)}$  vs  $r$  and  $\bar{u}$  for NCC, SAD, and 1-b SAD. The error distribution for each function is almost the same, where the error varies from zero to 2 phase quantization levels for up to 4 missing elements with up to  $0.1\lambda$  rms aberration. (one quantization level is  $0.023\lambda$ ). The standard deviation distributions of phase error measurements for all three functions show similar characteristics to the residual phase error [see Fig. 2(b)]. All combinations of missing elements and rms aberration levels under the 0.069 contour (3 quantization levels) are stable. Other combinations, however, result in very high standard deviations over different speckle data, and hence are not stable.

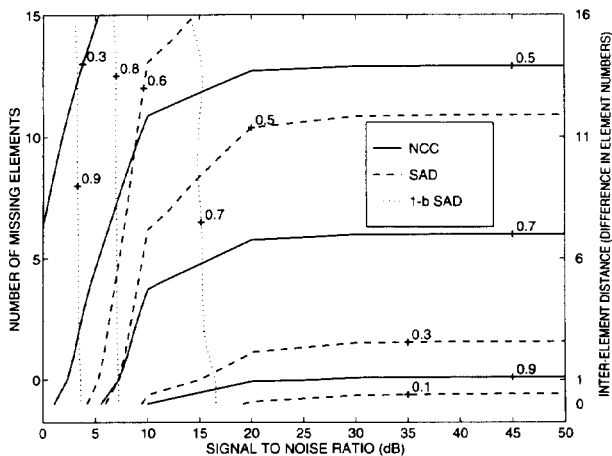


Fig. 3. Magnitude distribution of the cost functions versus the number of missing elements and SNR.

### C. Noise Performance

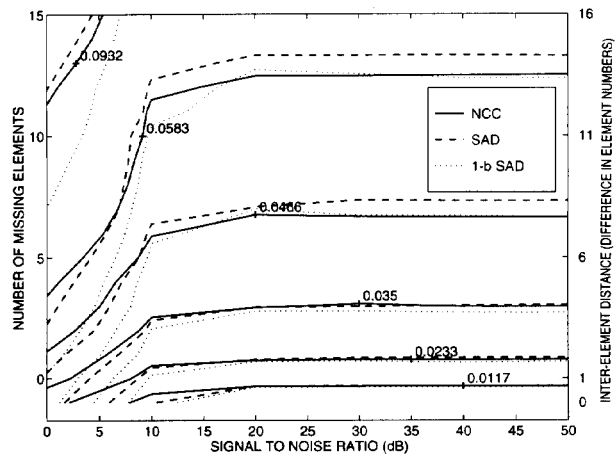
To test noise performance, measurements of magnitude and phase estimation error were performed for different SNR levels and missing elements. Fig. 3 shows the magnitude and residual phase error distributions for NCC, SAD and 1-b SAD functions versus SNR and number of missing elements. To obtain these results, the noisy signals,  $S_m^\alpha$  and  $S_n^\alpha$ , are generated using Eqs. 1 and 2 where scaling factors  $c_m(\alpha)$  and  $c_n(\alpha)$  determine SNR levels. These coefficients are updated for every signal pair used in the computation of the cost function.

To obtain measurements for different combinations of missing elements and SNR levels, the cost functions and phase estimation errors should be functions of only  $r$  and  $\alpha$ . Hence, no aberrations were employed, i.e.,  $u_i = 0$  for every  $i$ . Therefore, the definitions used in the previous parts of this section are modified so that the aberration dependence is replaced with the SNR dependence. As a result, the expressions given in (8) are modified as:

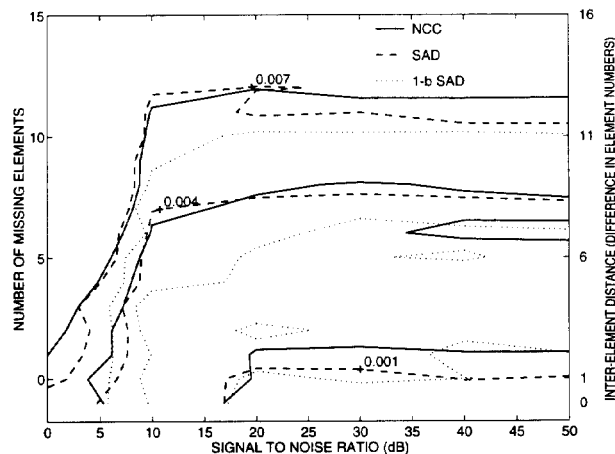
$$\begin{aligned}
 C_r^\alpha &= \frac{1}{N-r} \sum_{m=1}^{N-r} C_{m,m+r}(0, 0, \alpha) \\
 E_r^\alpha &= \frac{1}{N-r} \sum_{m=1}^{N-r} E_{m,m+r}(0, 0, \alpha) \\
 D_r^\alpha &= \frac{1}{N-r} \sum_{m=1}^{N-r} D_{m,m+r}(0, 0, \alpha).
 \end{aligned} \tag{14}$$

The rms and standard deviation were commutated over five sets of speckle data similar to those in (9) and (10). As a result, the new outputs become:  $\overline{C_r^\alpha}$ ,  $\overline{E_r^\alpha}$ ,  $\overline{D_r^\alpha}$ . Also note that, the cost functions of (2), (3), and (4) are computed with no aberration, i.e.,  $u_i = 0$ , and hence the resulting error is a function of only missing elements and SNR, not aberration. The resultant residual rms error, denoted as  $\overline{\Delta\phi(\alpha, r)}$ , was also computed on the same data.

Fig. 3 depicts the distributions of  $\overline{C_r^\alpha}$ ,  $\overline{E_r^\alpha}$ , and  $\overline{D_r^\alpha}$  vs the number of missing elements,  $r$ , and the SNR level,  $\alpha$ . For each function, the magnitude variation stays almost the same up to 20 dB SNR whereas a sharp change occurs for SNR less than 20 dB. The figure shows that 1-b SAD is



(a)



(b)

Fig. 4. Distribution of residual differential phase errors vs the number of missing elements and SNR. (a) rms (b) standard deviation. Contour values are given in fractions of a wavelength. The phase quantization level is  $0.023\lambda$ .

much more sensitive for SNR than fullword SAD and fullword NCC. The level of variation in 1-b SAD at high SNR values, however, is comparable to the noiseless case, although this is obscured in the figure by large magnitude variations at low SNR. In general, SAD is more sensitive to SNR than NCC. For SNR greater than 10 dB, the standard deviations of NCC, SAD, and 1-b SAD are within 10, 3, and 8%, respectively, of the corresponding magnitude values whereas the maximum standard deviation at 0 dB SNR equal 35, 6, and 10%, respectively.

Finally, the residual phase error versus SNR and missing elements is illustrated in Fig. 4(a) for NCC, SAD, and 1-b SAD. Each figure depicts the distribution of  $\overline{\Delta\phi(\alpha, r)}$  for each cost function. The functions, in general, show similar performance in phase estimation for different SNR levels. However, as implied by the magnitude measurements, the error of 1-b SAD is slightly higher than that of SAD and NCC at low SNR, especially at 0 dB. While the measured standard deviations for each function do not exceed one phase quantization level for SNR higher than 10 dB, they are less than two phase quantization levels for SNR less than 10 dB [see Fig. 4(b)]. As a result, standard deviation measurements

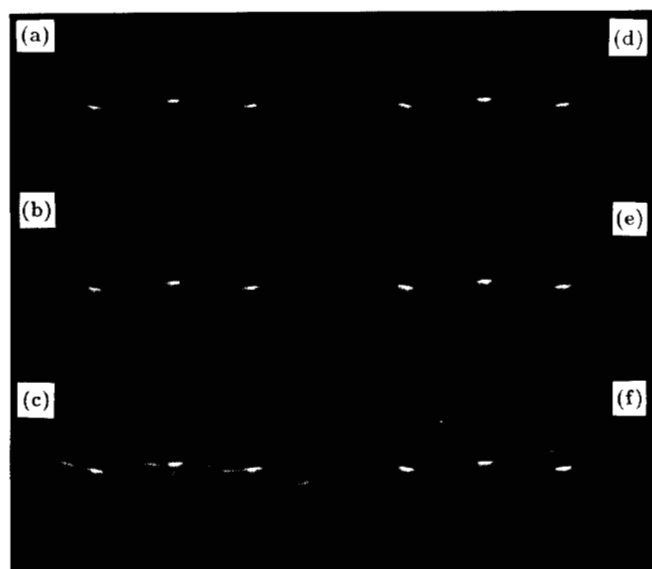


Fig. 5. B-scan sector images of a section of the phantom. Reconstruction parameters for each image are listed in Table I.

depict the stability of results for speckle data with SNR higher than 10 dB.

#### IV. B-SCAN IMAGES

To test the performance of different cost functions in time delay estimation, sector images of the phantom were reconstructed with and without missing elements and aberration. Each image of Fig. 5 shows the same section of the phantom representing a  $45^\circ$  sector angle over 48 mm range starting at 32 mm from the transducer. Images are displayed on a logarithmic scale with a 50 dB dynamic range.

For each corrected image, transmit and receive focus delays were updated using the phase aberration pattern estimated from diffuse scatterers. A 20 mm window length was used for time delay estimation by NCC, SAD, and 1-b SAD. Missing elements and phase distortions were applied both on transmit and receive. The original aberration pattern, which has an rms value of 1.40 radians (see Fig. 6), is applied by simply time shifting signals on channels. Estimated patterns shown in Fig. 6 were used to compensate phase aberrations on both transmit and receive. Missing elements were realized by zeroing RF signals both in transmit and receive beamforming. Other parameters used in image reconstruction are outlined in Table I.

Comparison of (a), (b), and (c) of Fig. 5 indicates that the degradation in image resolution due to aberration is much more severe than that caused by missing elements. The corrected images, (d), (e), and (f), are very similar, as predicted based on the measurements presented in the previous section. Corrected images are slightly degraded because of imperfect phase error compensation. This is due to the small estimation errors in relative phases between active element pairs. Also, estimation error in the relative phase between the 20th and 26th elements, the nearest active elements to the missing elements, produces a bias for phase estimates on elements 26 to 64.

The original aberration pattern shown in Fig. 6 has an rms value of  $0.222 \lambda$ . The number of missing elements is 5, and

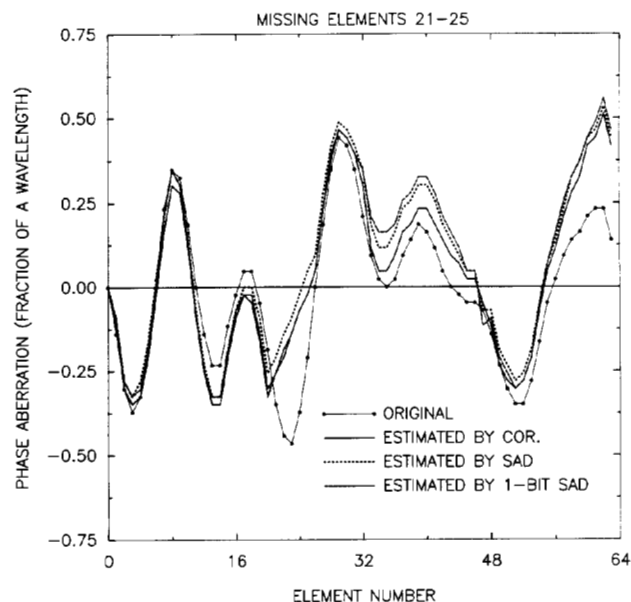


Fig. 6. The original and estimated phase aberration patterns across the array. Elements 21-25 are missing in aberration estimation.

TABLE I  
IMAGE RECONSTRUCTION PARAMETERS

Image	Missing Elements	Aberration	Aberration Estimation
a	-	-	-
b	21-25	-	-
c	21-25	✓	-
d	21-25	✓	NCC
e	21-25	✓	SAD
f	21-25	✓	1-b SAD

the correlation coefficient in Fig. 1 corresponding to these parameters is about 0.3. The rms residual *differential* phase errors of estimates of NCC, SAD, and 1-b SAD are  $0.102 \lambda$ ,  $0.102 \lambda$ , and  $0.108 \lambda$  whereas the corresponding rms residual *unwrapped* phase errors are  $0.115 \lambda$ ,  $0.138 \lambda$ , and  $0.138 \lambda$ , respectively. Although the reduction in overall phase error is only about fifty percent, a dramatic image quality improvement is obtained. This is because the final residual errors are mainly due to the propagation of differential phase errors resulting in a bias on elements 26-64 (see Fig. 6). Since this bias is relatively small compared to the overall phase distortion, its effect on image quality is not significant.

#### V. DISCUSSION AND CONCLUSION

In general, combinations of the number of missing elements, rms aberration and SNR levels resulting in correlation values higher than fifty percent of the autocorrelation value can be used for aberration estimation. The measurements show

that, for such combinations, NCC, SAD, and 1-b SAD show comparable performance.

For aberration correction in the presence of missing elements, inactive elements must be detected before aberration estimation and beamforming. This can be achieved by computing the rms signal amplitude at each channel over a set of range windows. In practical applications, the processor performing computation of the cost function can also be used for this purpose [14]. If detection of an inactive element, however, fails, then the corresponding differential delays will be incorrect resulting in significant errors in unwrapped phase estimates.

All phase error measurements, which were performed on differential phase estimates, do not include the propagation of differential phase errors across the array through phase unwrapping. The differential residual phase error is a direct measure for comparison of different cost functions in aberration estimation, and the influence of error propagation on aberration correction is identical for each cost function. In general, propagation of differential errors is noticeable if the accumulated error is significant compared to the overall aberration, and becomes a drawback in aberration correction based on neighboring elements.

All SNR analysis in this study assumed that the original data are noiseless. In fact the original data are quite noisy. Additional noise is superimposed on these signals to illustrate trends in estimation error as the SNR is reduced. The SNR quoted here, therefore, should not be considered the absolute SNR expected from array data. In other words, better noise performance of the aberration estimation schemes is expected on real phased array data. This is because experimental data used in this study were obtained through a synthetic aperture approach where only one element was fired at a time, and thus SNR of the RF signal on a channel after transmit beamforming with  $N$ -elements is proportional to  $\sqrt{N}$ . However, for a phased array system where  $N$ -elements are active in transmit, the SNR of the received RF signal on a channel becomes proportional to  $N$ . On the other hand, since measurements for different SNR levels presented here were performed with no aberration, the performance of estimation schemes will be degraded further in the presence of finite aberrations.

One can attempt to recover lost *differential* delays associated with missing elements using a different interpolation technique. We examined this possibility using a simple scheme based on bilinear interpolation. The lost differential delay is interpolated using two terms: one involves the differential delay between nearest operable elements whereas the second term is due to bilinear interpolation using the measured differential delays of active element pairs neighboring to the inactive elements. This scheme, as expected, better recovers the lost delays. Misalignment of the phasing of two subapertures, however, is worse than that of (7). This effect can be reduced by using more complicated interpolation techniques such as a lowpass filtering of a size comparable to the array size, but with increased computational complexity. In fact, the critical issue in aberration estimation with inactive elements is the accurate phase alignment of two subapertures, where the interpolated *differential* delays are used only for this purpose.

Hence, the simple scheme of (7) is a good choice both in terms of accuracy and computational efficiency.

While aberration correction based on 1-b SAD is computationally more efficient compared to fullword SAD and fullword NCC, its accuracy is lower for low SNR levels. This limitation, however, can be relaxed by averaging the estimates over a number of beams [12], and/or increasing the estimation window used in 1-b SAD computation [16].

The correlation function as defined in (3) acts as the reference covariance measure for comparison of the SAD-based aberration estimation measurements. It is defined in its widely used normalized form, and computed accordingly. Normalization is crucial for imaging with wide band signals. It can be eliminated, however, for imaging involving sufficiently narrow band signals, and hence its one bit version can also be used in phase estimation. Use of the correlation function without normalization must be tested for phase estimation using RF signals with different band widths. Furthermore, the computational complexity of such methods must be compared to efficient computation techniques based on CORDIC processing [14].

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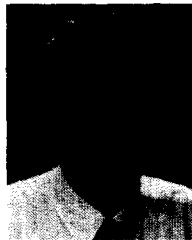
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